

Notice of References Cited	Application/Control No. 10/644,290	Applicant(s)/Patent Under Reexamination KANG ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,144,203	09-1992	Fujita et al.	315/169.3
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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